

**July 2011** 

# FDD8453LZ\_F085

# N-Channel Power Trench<sup>®</sup> MOSFET 40V, 50A, 6.5m $\Omega$

#### **Features**

- Typ  $r_{DS(on)}$  = 5m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 15A
- Typ  $r_{DS(on)}$  = 6m $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 13A
- HBM ESD protection level > 7kv typical
- RoHS Compliant
- Qualified to AEC Q101

### **General Description**

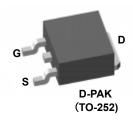
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and switching loss. G-S zener has been added to enhance ESD voltage level.

### **Applications**

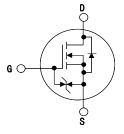
- Inverter
- Synchronous Rectifier



### **Package**



## **Symbol**



### **MOSFET Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain to Source Voltage	40	V
$V_{GS}$	Gate to Source Voltage	±20	V
	Drain Current - Continuous (Package limited) T <sub>C</sub> = 25°C	50	А
'D	-Pulsed	Figure4	A
E <sub>AS</sub>	Single Pulse Avalanche Energy (N	ote 1) 88	mJ
П	Power Dissipation	118	W
$P_{D}$	Dreate above 25°C	0.79	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to + 175	°C

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance Junction to Case	1.27	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient, 1in <sup>2</sup> copper pad area	52	°C/W

### **Package Marking and Ordering Information**

**Parameter** 

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8453LZ	FDD8453LZ_F085	D-PAK(TO-252)	13"	12mm	2500 units

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Off Cha	racteristics					
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$	40	-	-	V

**Test Conditions** 

Min

Max

Units

B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$	40	-	-	V
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 32V,	-	-	1	
I <sub>DSS</sub> Zero Gate voltage Drain Current	$V_{GS} = 0V$ $T_C = 150^{\circ}C$	-	-	250	μΑ	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V$	-	-	±100	nA

### On Characteristics

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.8	3.0	V
		I <sub>D</sub> = 15A, V <sub>GS</sub> = 10V	-	5.0	6.5	mΩ
r <sub>DS(on)</sub>	Drain to Source On Resistance	I <sub>D</sub> = 13A, V <sub>GS</sub> = 4.5V	-	6.0	7.8	mΩ
		$I_D = 15A, V_{GS} = 10V T_J = 175^{\circ}C$	-	9.4	12.2	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5V, I_{D} = 15A$	-	91	-	S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	.,	0) (	-	2935	-	pF
C <sub>oss</sub>	Output Capacitance		$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz		340	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112			260	-	pF
$R_g$	Gate Resistance	f = 1MHz		-	1.8	-	Ω
$Q_{g(ToT)}$	Total Gate Charge at 10V	$V_{GS} = 0$ to 10V	V <sub>DD</sub> = 20V	-	60	78	nC
$Q_{g(5)}$	Total Gate Charge at 5V	$V_{GS} = 0$ to 5V	I <sub>D</sub> = 15A	-	32	42	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		I <sub>g</sub> =1mA	-	7.5	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge			-	13	-	nC

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Switch	ing Characteristics					

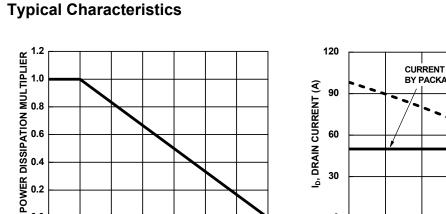
t <sub>on</sub>	Turn-On Time		-	-	34	ns
t <sub>d(on)</sub>	Turn-On Delay Time		-	12	-	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 20V, I <sub>D</sub> = 15A,	-	10	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10V, $R_{GEN}$ = $6\Omega$	-	43	-	ns
t <sub>f</sub>	Fall Time		-	7	-	ns
t <sub>off</sub>	Turn-Off Time		-	-	80	ns

#### **Drain-Source Diode Characteristics**

V <sub>SD</sub> Source to Drain Diode Voltage		I <sub>SD</sub> = 2A	-	0.7	1.2	V
<b>v</b> SD	V <sub>SD</sub> Source to Drain Diode Voltage	I <sub>SD</sub> = 15A	-	0.8	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	L = 15A dl /dt = 100A/	-	25	33	ns
Q <sub>rr</sub>	Reverse Recovery Charge	-I <sub>F</sub> = 15A, dI <sub>SD</sub> /dt = 100A/μs	-	14	19	nC

1: Starting  $T_J$  = 25°C, L = 0.11mH,  $I_{AS}$  = 40A,  $V_{DD}$  = 36V during inductor charging and  $V_{DD}$  = 0V during the time in Avalanche.

This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at: http://www.aecouncil.com/
All Fairchild Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.



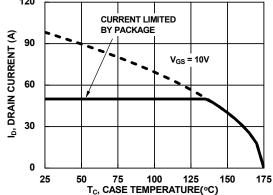


Figure 1. Normalized Power Dissipation vs Case Temperature

T<sub>C</sub>, CASE TEMPERATURE(°C)

75

100

125

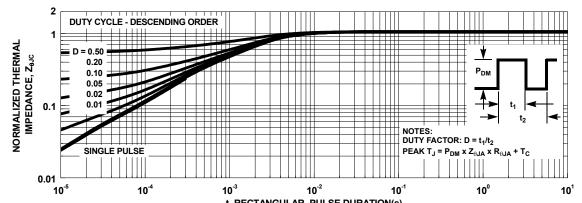
150

0.0

0

25

Figure 2. Maximum Continuous Drain Current vs Case Temperature



t, RECTANGULAR PULSE DURATION(s)
Figure 3. Normalized Maximum Transient Thermal Impedance

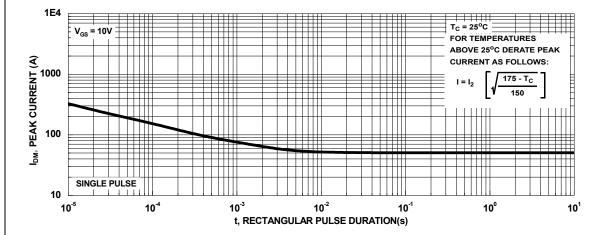


Figure 4. Peak Current Capability

### **Typical Characteristics**

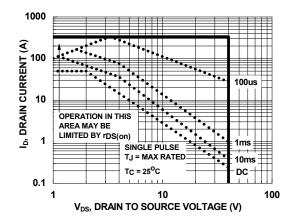
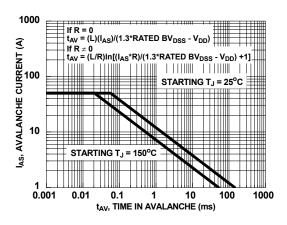


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching

Capability

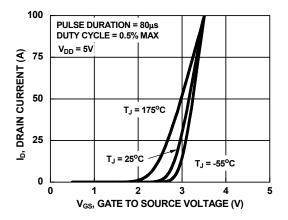


Figure 7. Transfer Characteristics

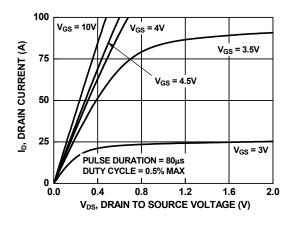


Figure 8. Saturation Characteristics

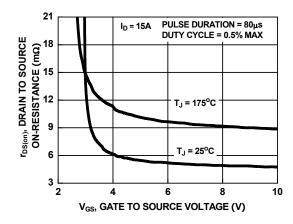


Figure 9. Drain to Source On-Resistance Variation vs Gate to Source Voltage

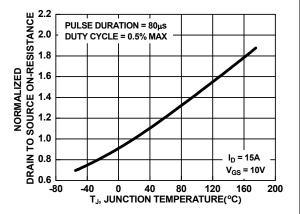


Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

## **Typical Characteristics**

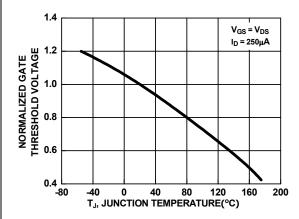


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

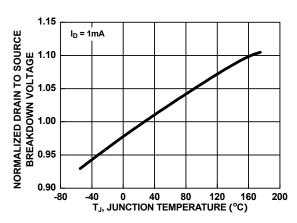


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

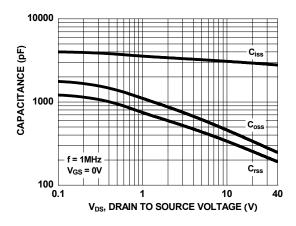


Figure 13. Capacitance vs Drain to Source Voltage

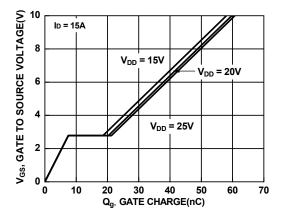


Figure 14. Gate Charge vs Gate to Source Voltage





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